

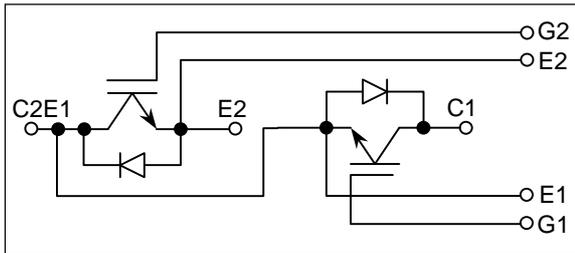
# MBM200GR12A

[Rated 200A/1200V, Dual-pack type]

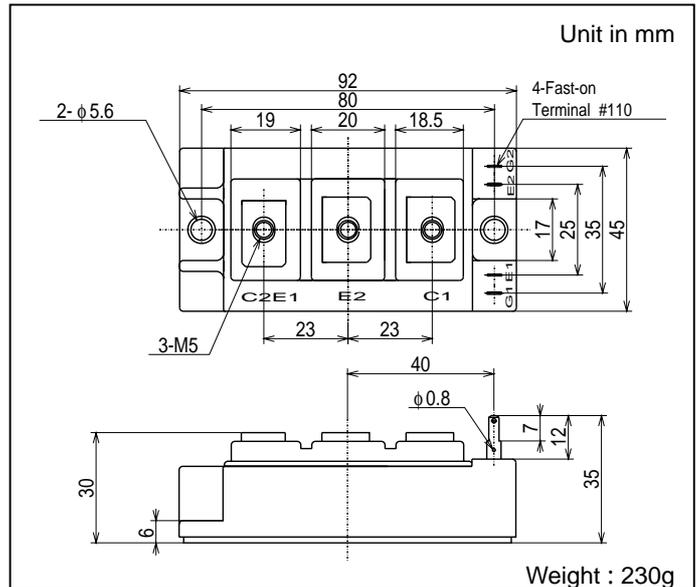
## FEATURES

- Low saturation voltage and high speed.
- Low turn-OFF switching loss.
- Low noise due to built-in free-wheeling diode.  
(Ultra Soft and Fast recovery Diode (USFD))
- High reliability structure.
- Isolated heat sink (terminals to base).

## CIRCUIT DIAGRAM



## OUTLINE DRAWING



## ABSOLUTE MAXIMUM RATINGS (T<sub>c</sub>=25°C)

Item	Symbol	Unit	Value
Collector-Emitter Voltage	V <sub>CEs</sub>	V	1200
Gate-Emitter Voltage	V <sub>GES</sub>	V	±20
Collector Current	DC	I <sub>C</sub>	200
	1ms	I <sub>CP</sub>	400
Forward Current	DC	I <sub>F</sub>	200 <sup>*1</sup>
	1ms	I <sub>FM</sub>	400
Collector Power Dissipation	P <sub>C</sub>	W	1250
Junction Temperature	T <sub>j</sub>	°C	-40 ~ +150
Storage Temperature	T <sub>stg</sub>	°C	-40 ~ +125
Isolation Voltage	V <sub>iso</sub>	V <sub>RMS</sub>	2500(AC 1 minute)
Screw Torque	Terminals	—	1.96 <sup>*2</sup>
	Mounting		1.96 <sup>*3</sup>

Notes; \*1 : RMS current of diode ≤ 60 Arms

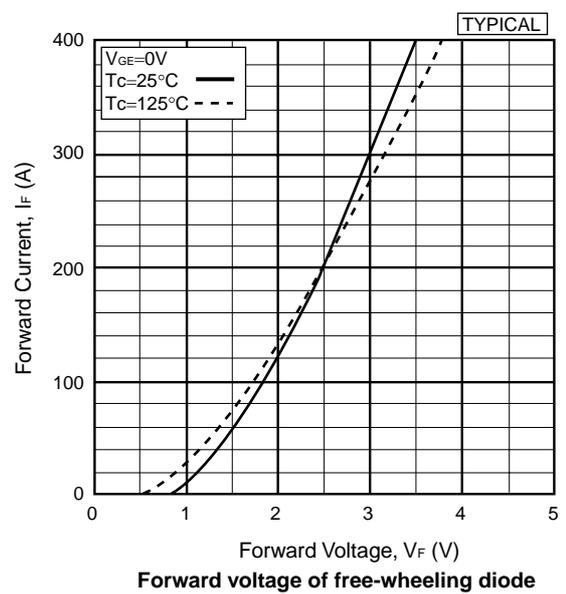
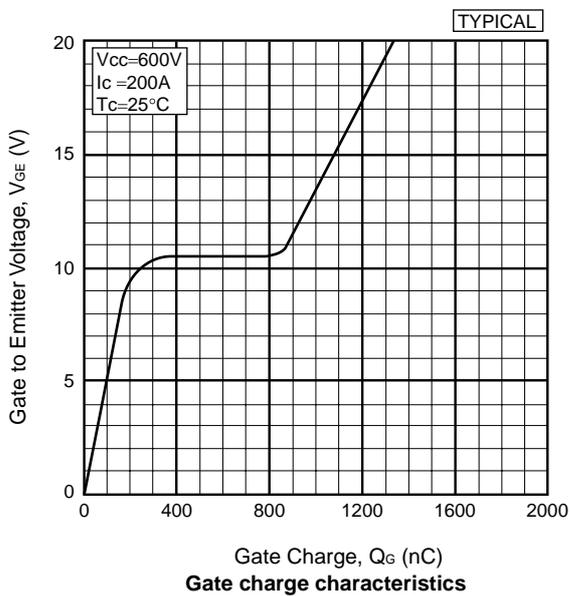
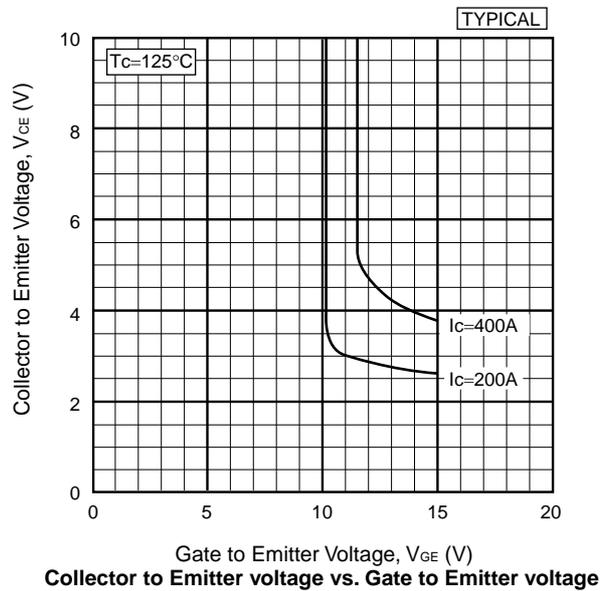
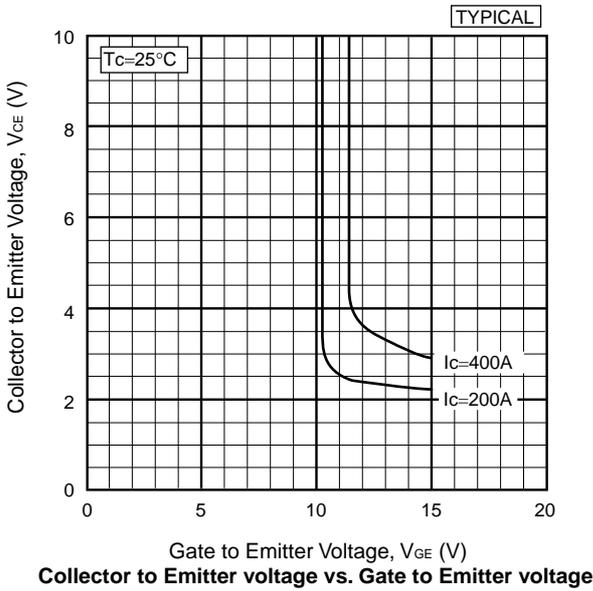
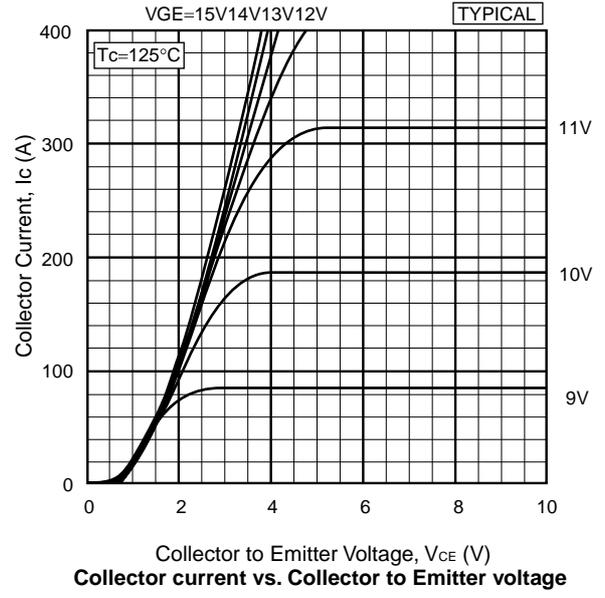
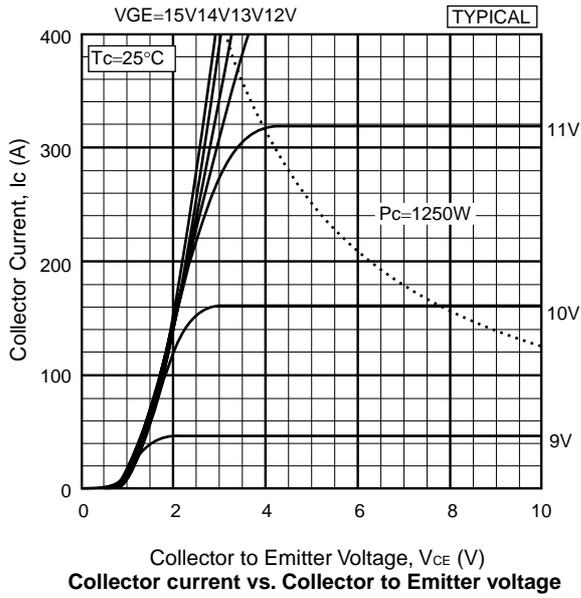
\*2, \*3 : Recommended value 1.67 N·m

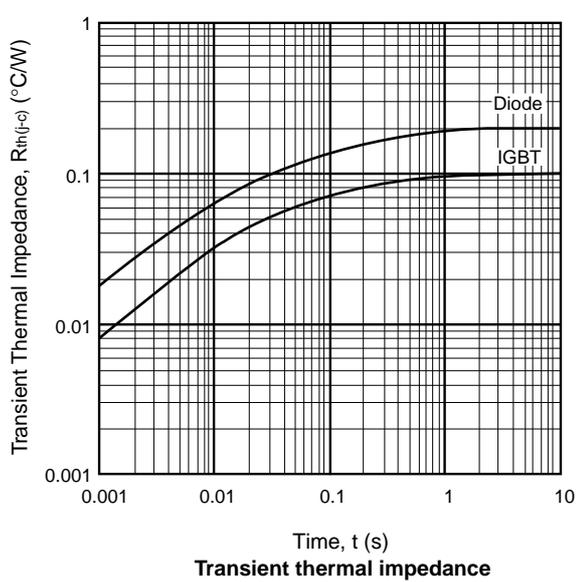
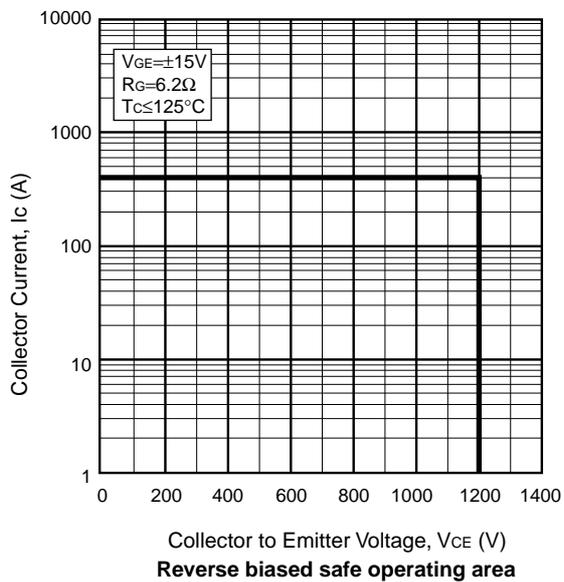
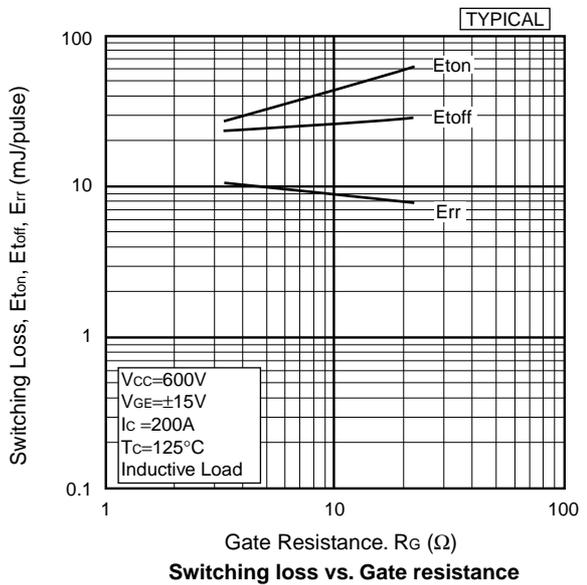
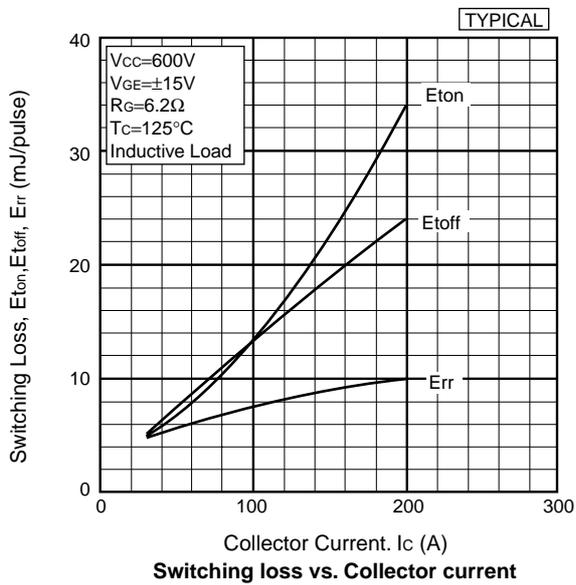
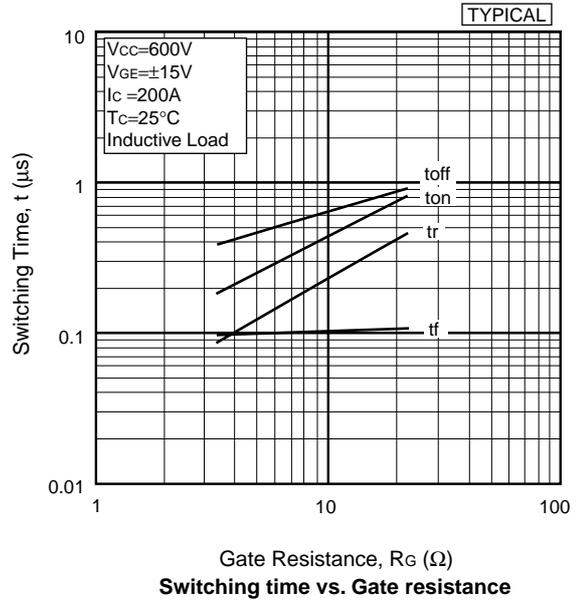
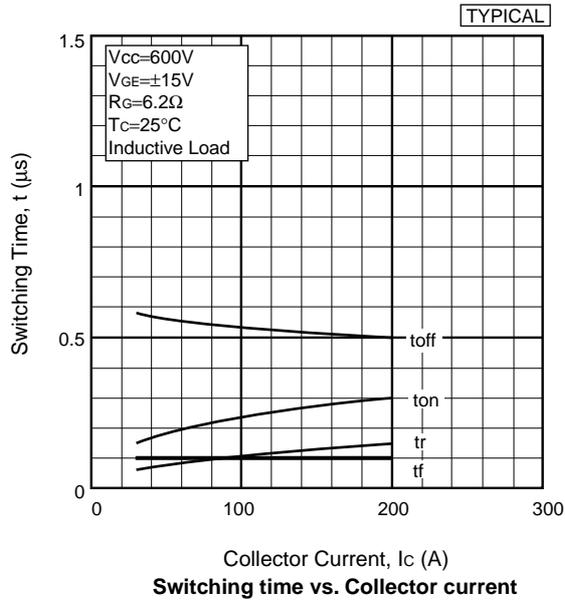
## CHARACTERISTICS (T<sub>c</sub>=25°C)

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions	
Collector-Emitter Cut-Off Current	I <sub>CEs</sub>	mA	—	—	1.0	V <sub>CE</sub> =1200V, V <sub>GE</sub> =0V	
Gate-Emitter Leakage Current	I <sub>GES</sub>	nA	—	—	±500	V <sub>GE</sub> =±20V, V <sub>CE</sub> =0V	
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>	V	—	2.2	2.8	I <sub>C</sub> =200A, V <sub>GE</sub> =15V	
Gate-Emitter Threshold Voltage	V <sub>GE(TO)</sub>	V	—	—	10	V <sub>CE</sub> =5V, I <sub>C</sub> =200mA	
Input Capacitance	C <sub>ies</sub>	pF	—	18000	—	V <sub>CE</sub> =10V, V <sub>GE</sub> =0V, f=1MHz	
Switching Times	Rise Time	t <sub>r</sub>	—	0.15	0.3	V <sub>CC</sub> =600V, I <sub>C</sub> =200A R <sub>G</sub> =6.2Ω <sup>*4</sup> V <sub>GE</sub> =±15V Inductive Load I <sub>F</sub> =200A	
	Turn-On Time	t <sub>on</sub>	—	0.3	0.6		
	Fall Time	t <sub>f</sub>	—	0.1	0.3		
	Turn-Off Time	t <sub>off</sub>	—	0.5	1.0		
Reverse Recovery Time	t <sub>rr</sub>	μs	—	0.2	0.4		
Peak Forward Voltage Drop	V <sub>FM</sub>	V	—	2.5	3.5	I <sub>F</sub> =200A, V <sub>GE</sub> =0V	
Thermal Impedance	IGBT	R <sub>th(j-c)</sub>	°C/W	—	—	0.1	Junction to case
	FWD	R <sub>th(j-c)</sub>					

Notes; \*4 : R<sub>G</sub> value is the test condition's value for decision of the switching times, not recommended value, please determine the suitable R<sub>G</sub> value after the measurement of switching waveforms (overshoot voltage, etc.) with appliance mounted.

Remark; For actual application, please confirm this spec. sheet is the newest revision.





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